Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/074,745	SCHULTZ ET AL.	
Examiner	Art Unit	
Mark L. Shibuya	1639	

	SEAR	CHED	
Class	Subclass	Date	Examiner
526	65	8/1/2005	ny
526	66		
427	2.11	4	X
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
526	65	8/1/2006	dus		
526	66				
427	2.11	<u>_</u>			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Interference search	8/1/2005	MS	
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